

SEMITOP[®] 2

IGBT Module

SK60GAL128 SK60GAR128

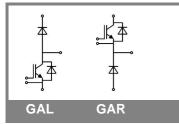
Preliminary Data

Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB
- High short circuit capabilit
- SPT= Soft-Punch-Through technology
- V_{ce,sat} with positive coefficient

Typical Applications

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



Absolute Maximum Ratings T _s = 25 °C, unless otherwise specifie					
Symbol	Conditions		Values	Units	
IGBT	_			_	
V _{CES}	T _j = 25 °C		1200	V	
I _C	T _j = 125 °C	T _s = 25 °C	63	А	
		T _s = 80 °C	44	А	
I _{CRM}	I _{CRM} = 2 x I _{Cnom}		100	А	
V _{GES}			± 20	V	
t _{psc}	V_{CC} = 600 V; $V_{GE} \le 20$ V; VCES < 1200 V	T _j = 125 °C	10	μs	
Inverse D	Diode				
I _F	T _i = 150 °C	T _s = 25 °C	33	А	
		T _s = 80 °C	23	А	
I _{FRM}	I _{FRM} = 2 x I _{Fnom}			А	
I _{FSM}	t _p = 10 ms; half sine wave	T _j = 150 °C	110	А	
Freewhee	eling Diode		·		
I _F	T _j = 150 °C	T _{case} = 25 °C	57	А	
		T _{case} = 80 °C	38	А	
I _{FRM}				А	
I _{FSM}	t _p = 10 ms; half sine wave	T _j = 150 °C	550	А	
Module					
I _{t(RMS)}				А	
T _{vj}			-40 +150	°C	
T _{stg}			-40 +125	°C	
V _{isol}	AC, 1 min.		2500	V	

Characteristics T _s =		25 °C, unless otherwise specified				
Symbol	Conditions		min.	typ.	max.	Units
IGBT						
V _{GE(th)}	V_{GE} = V_{CE} , I_C = 2 mA		4,5	5,5	6,5	V
I _{CES}	V_{GE} = 0 V, V_{CE} = V_{CES}	T _j = 25 °C			0,1	mA
		T _j = 125 °C		0,2		mA
I _{GES}	V _{CE} = 0 V, V _{GE} = 20 V	T _j = 25 °C			200	nA
1		T _j = 125 °C				nA
V _{CE0}		T _j = 25 °C		1,1	1,3	V
		T _j = 125 °C		1	1,2	V
r _{CE}	V _{GE} = 15 V	T _j = 25°C		16		mΩ
		T _j = 125°C		18		mΩ
V _{CE(sat)}	I _{Cnom} = 50 A, V _{GE} = 15 V	T _j = 25°C _{chiplev.}	1,7	1,9	2,3	V
		T _j = 125°C _{chiplev.}		1,9	2,3	V
C _{ies}				4,46		nF
C _{oes}	V_{CE} = 25, V_{GE} = 0 V	f = 1 MHz		0,33		nF
C _{res}				0,21		nF
t _{d(on)}				80		ns
t,	R_{Gon} = 15 Ω	V _{CC} = 600V		50		ns
Ė _{on}	D (5.0	I _{Cnom} = 50A		5,8		mJ
^t d(off)	R_{Goff} = 15 Ω	$T_{j} = 125 \text{ °C}$		420		ns
t _f		V _{GE} =±15V		40		ns
E _{off}				4,8		mJ
R _{th(j-s)}	per IGBT				0,6	K/W



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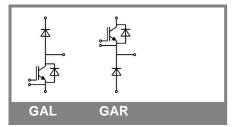
Typical Applications

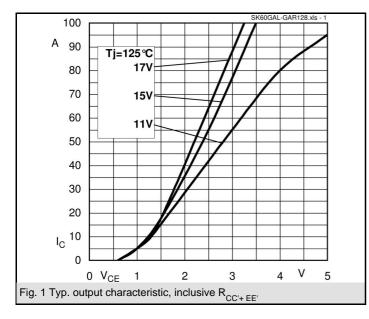
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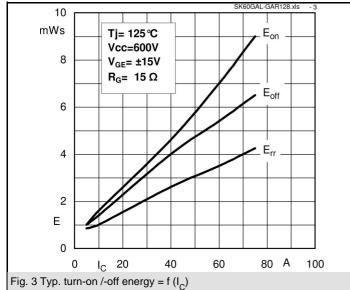
Symbol	Conditions		min.	typ.	max.	Units
Inverse D				.96.	maxi	
	I _{Fnom} = 10 A; V _{GE} = 0 V	T _i = 25 °C _{chipley}		2	2,5	V
I LO	Thom SE	$T_j = 125 \ ^{\circ}C_{chiplev}$		1,8	2,3	V
V _{F0}		T _j = 125 °C		1,2		V
r _F		T _j = 125 °C		62,7		mΩ
I _{RRM}	I _{Fnom} = 10 A	T _i = 125 °C		12		Α
Q _{rr}	di/dt = -300 A/µs	1		1,8		μC
E _{rr}	V _{CC} = 600V			0,4		mJ
R _{th(j-s)D}	per diode				2,1	K/W
	eling Diode					•
$V_F = V_{EC}$	I _{Fnom} = 50 A; V _{GE} = 0 V	T _j = 25 °C _{chiplev.}		2		V
		T _j = 125 °C _{chiplev.}		1,8		V
V _{F0}		T _j = 125 °C		1	1,2	V
r _F		T _j = 125 °C		18	22	V
I _{RRM}	I _{Fnom} = 50 A	T _i = 125 °C		40		Α
Q _{rr}	di/dt = -800 A/µs	,		8		μC
E _{rr}	V _R =600V			2,3		mJ
R _{th(j-s)FD}	per diode				0,9	K/W
M _s	to heat sink M1				2	Nm
w				21		g

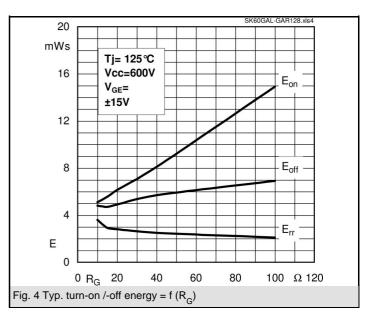
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

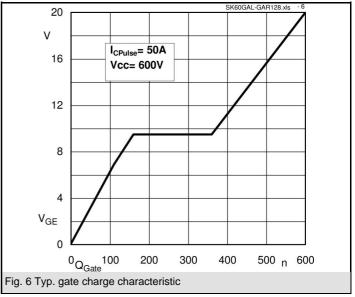
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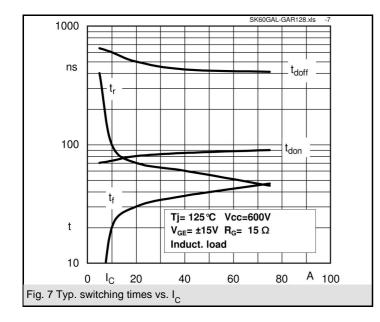


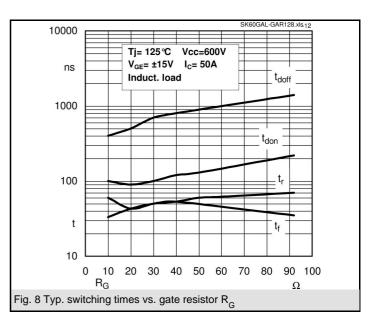


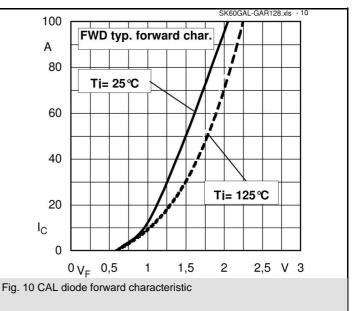




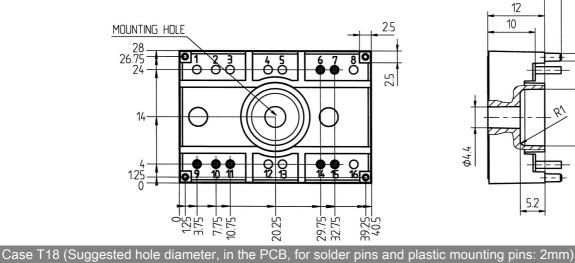


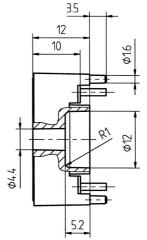






UL recognized file 67 901 14C Ф Ø14.5 3.43 15.43 10.5





no. E 63 532

Δ 15 15 10 0 1 8 6 6 7 1 Case T18 GAR Case T18 GAL